Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10596707	ASTELY, DAVID
Examiner	Art Unit
Nauven Hai V	2618

	Nguyen, Hai V		

SEARCHED				
Class		Subclass	Date	Examiner
455	552		02/25/2008	HN

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT;	02/25/2008	HN	
IBM_TDB) (see search history printout report)			
EAST search updated (see search history printout report)	01/15/2009	HN	

INTERFERENCE SEARCH					
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